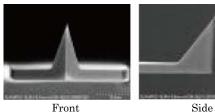
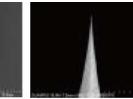


Probe

The probe is a sharpened tetrahedral. The probe is fabricated on the exact end of each cantilever.





Front

Front (probe apex)

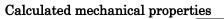
Dimensions

| | | Typical value | Typical range |
|----------------|--------|-----------------------|---------------|
| Probe length | (µm) | 14 | 9 - 19 |
| Tip radius | (nm) | 7 | 4 - 10 |
| Probe | | (axis) less | than 17.5 |
| tip half angle | (deg.) | (side) less than 17.5 | |
| Probe side | | (front) 0, (back) 35 | |
| tip angle | (deg.) | (side) 18, 18 | |

Cantilever

Dimensions

| Cantilever length L (µm) | 160 (±15) | - |
|-----------------------------------|------------|-----|
| Cantilever width W (µm) | 40 (±2) | . Î |
| Cantilever thickness t (μ m) | 3.7 (±0.5) | |



| _ | | Typical value | Typical range |
|------------|----------------|---------------|---------------|
| Resonant f | requency (kHz) | 300 | 200 - 400 |
| Spring con | stant (N/m) | 26 | 8.4 - 57 |



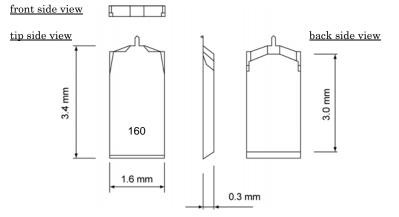
OMCL-AC160TN-C3

w

Chip

There is a rectangular cantilever on one side of the silicon chip.

Dimension



Material

| Tip & Lever | Silicon (n-type,0.01 – 0.02 ohm.cm) | |
|------------------------------|-------------------------------------|--|
| Metal coating (tip side) | Non | |
| Metal coating (ref; ex side) | Non | |
| Chip | Silicon (n-type,0.01 – 0.02 ohm.cm) | |